

**Search Notes**

Application/Control No.

09/965,772

Examiner

Quoc A. Tran

Applicant(s)/Patent under  
Reexamination

AMANO, TOMIO

Art Unit

2176

**SEARCHED**

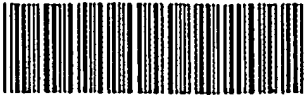
Class	Subclass	Date	Examiner
715	513	10/22/2005	
715	523	10/22/2005	
715	536	10/22/2005	
707	4	10/22/2005	
704	7	10/22/2005	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PAT, US-PGPUB, EPO, JPO, Derwent, IBM_TDB DataBase (see Search History Printout)	10/22/2005	
IEEE DataBase (see search history printout)	10/22/2005	

<b>Search Notes</b> 	<b>Application No.</b>		<b>Applicant(s)</b>	
	09/965,772		AMANO, TOMIO	
	<b>Examiner</b>		<b>Art Unit</b>	
	Quoc A. Tran		2176 /	

SEARCHED			
Class	Subclass	Date	Examiner
715	513 523 536	9/28/04	Q
704	7		
707	4		
345	173		
update above		5/16/05	Q

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
INVENTOR SEARCH CHECK FOR double patent VS PAT, PLUS + FIC VS PGPUB, IBM-TDO FPO, IPO, DERIVANT update above	9/28/04 ↓ 5/16/05	Q ↓ Q